

Enhancement Mode Single N-Channel Power MOSFET

 $SOP8/NMOS/30V/\pm 20V/1.5V/11.8A/12m\Omega$

Rev_{0.1}





30V, 12mΩ,11.8A,Dual N-Channel

1.Features

- ♦ 30V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

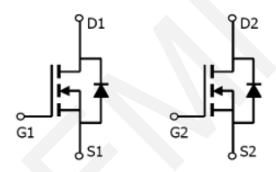
		4.
2.Ap	plica	ations

- ◆ Power Switching Application
- Load Switching



Pin Description

V _{DS}	R _{DS(on)} Typ.	I _D Max.
201/	12mΩ @ 10V	44.04
30V	15mΩ @ 4.5V	11.8A



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX012D03D8	012D03	SOP8	3,000	60,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{ extsf{DSS}}$	30	٧
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I_D	11.8	А
Drain Current (Pulse), PW≤300μs	I _{DP}	47	Α
Total Dissipation	P_{D}	2.5	W
Avalanche Energy, Single Pulsed	E _{AS}	86	mJ
Junction Temperature	T_j	150	$^{\circ}\mathrm{C}$
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to Case	R _{eJC}	50	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

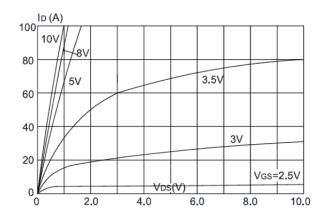
6.Electrical Characteristics at Ta=25°C (Note 3)

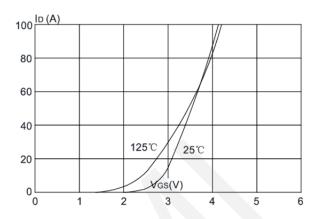
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	-	٧
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1.0	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	ı	i	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =250μA	1.0	1.5	2.5	V
Static Drain to Source On-State	Б	I _D = 20A, V _{GS} = 10V	-	12	16	mΩ
Resistance	R _{DS(on)}	$I_D = 10A, V_{GS} = 4.5V$	-	15	22	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,	-	900	-	pF
Output Capacitance	Coss	V _{DS} =15V,	-	140	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	-	120	-	pF
Turn-ON Delay Time	t _{d(on)}		ı	6	-	ns
Rise Time	t _r	$V_{DD} = 15V, I_D = 10A,$	-	5	-	ns
Turn-OFF Delay Time	$t_{\text{d(off)}}$	$V_{GS} = 10V, R_G = 1\Omega,$ $R_L = 6\Omega$	-	25	-	ns
Fall Time	t _f		-	7	-	ns
	Q_g	V _{DS} = 15V,	-	19	-	nC
Total Gate Charge	Q _{gs}	V _{GS} = 10V,	-	6.3	-	nC
	Q_{gd}	I _{DS} = 10A	-	4.5	-	nC
Diode Forward Voltage	V_{FSD}	I _S = 20A, V _{GS} = 0V	0.5	-	1.2	٧

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

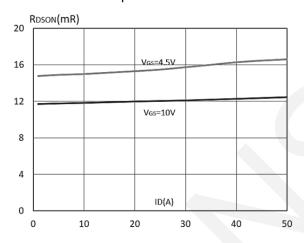


7. Typical electrical and thermal characteristics

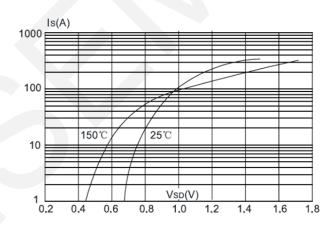




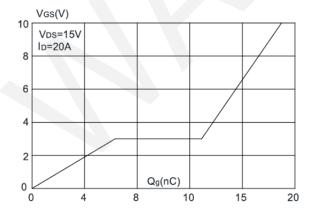
Output Characteristics



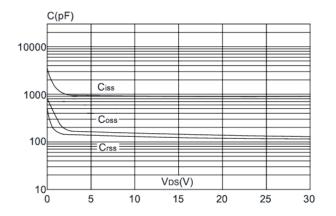
Typical Transfer Characteristics



On-resistance vs. Drain Current



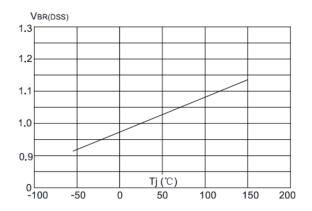
Body Diode Characteristics



Gate Charge Characteristics

Capacitance Characteristics





Ros(on)

2.5

1.0

0.5

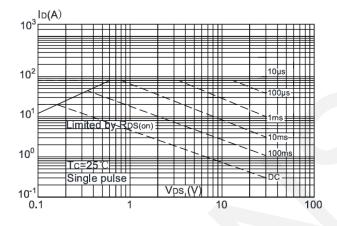
-100 -50 0 50 100 150 200

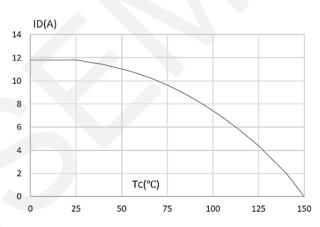
Normalized Breakdown Voltage vs.

Normalized on Resistance vs.

Junction Temperature

Junction Temperature

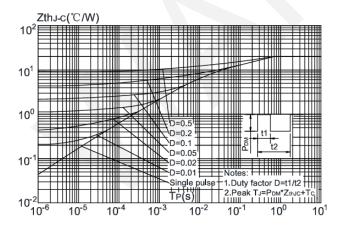




Maximum Safe Operating Area

Maximum Continuous Drain Current vs.

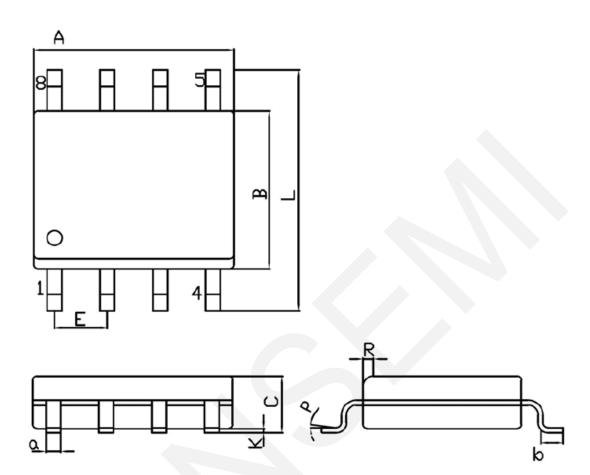
Case Temperature



Normalized Maximum Transient Thermal Impedance



8.Package Dimensions



Symbol	Dimensions In Millimeters		Symbol Dimensions I		in Millimeters	
Symbol	Min	Max	Symbol	Min	Max	
A	4.70	5,10	С	1,35	1,75	
В	3.70	4,10	۵	0.35	0.49	
L	5.80	6,20	R	0'30	0.60	
E	1.27BSC		Р	0+	7*	
K	0.12	0.22	b	0.40	1,25	



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